

EMC1182

Dual Channel 1°C Temperature Sensor with Beta Compensation and 1.8V SMBus Communications

PRODUCT FEATURES

Datasheet

General Description

The EMC1182 is a high accuracy, low cost, 1.8V System Management Bus (SMBus) compatible temperature sensor. Advanced features such as Resistance Error Correction (REC), Beta Compensation (to support CPU diodes requiring the BJT/transistor model including 65nm and lower geometry processors) and automatic diode type detection combine to provide a robust solution for complex environmental monitoring applications. The ability to communicate at 1.8V SMBus levels provides compatible I/O for the advanced processors found in today's tablet and smartphone applications.

The EMC1182 monitors two temperature channels (one external and one internal), providing $\pm 1^\circ\text{C}$ accuracy for both external and internal diode temperatures.

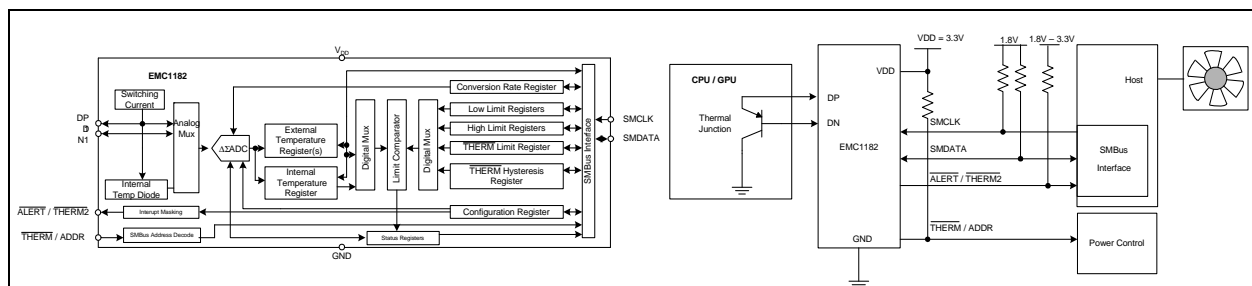
REC automatically eliminates the temperature error caused by series resistance allowing greater flexibility in routing thermal diodes. Frequency hopping* and analog filters ensure remote diode traces can be as far as eight (8) inches without degrading the signal. Beta Compensation eliminates temperature errors caused by low, variable beta transistors common in today's fine geometry processors. The automatic beta detection feature monitors the external diode/transistor and determines the optimum sensor settings for accurate temperature measurements regardless of processor technology. This frees the user from providing unique sensor configurations for each temperature monitoring application. These advanced features plus $\pm 1^\circ\text{C}$ measurement accuracy provide a low-cost, highly flexible and accurate solution for critical temperature monitoring applications.

Applications

- Notebook Computers
- Desktop Computers
- Industrial
- Embedded applications

Features

- Support for diodes requiring the BJT/transistor model
 - Supports 65nm and lower geometry CPU thermal diodes
- Pin and register compatible with EMC1412
- Automatically determines external diode type and optimal settings
- Resistance Error Correction
- Frequency hops the remote sample frequency to reject DC converter and other coherent noise sources*
- Consecutive Alert queue to further reduce false Alerts
- Up to 1 External Temperature Monitor
 - 25°C typ, $\pm 1^\circ\text{C}$ max accuracy ($20^\circ\text{C} < T_{\text{DIODE}} < 110^\circ\text{C}$)
 - 0.125°C resolution
 - Supports up to 2.2nF diode filter capacitor
- Internal Temperature Monitor
 - $\pm 1^\circ\text{C}$ accuracy
 - 0.125°C resolution
- 3.3V Supply Voltage
- 1.8V SMBus operation
- Programmable temperature limits for ALERT/THERM2 (85°C default high limit and 0°C default low limit) and THERM (85°C default)
- Available in small 8-pin 2mm x 3mm TDFN RoHS compliant package
- Available in small 8-pin 3mm x 3mm DFN RoHS compliant package



* Technology covered under the US patent 7,193,543.

Ordering Information:

| ORDERING NUMBER | PACKAGE | FEATURES | SMBUS ADDRESS |
|------------------|--|---|--|
| EMC1182-A-AC3-TR | 8-pin TDFN 2mm x 3mm (RoHS compliant) | Two temperature sensors, $\overline{\text{ALERT/THERM2}}$ and $\overline{\text{THERM}}$ pins, fixed SMBus address | Selectable via $\overline{\text{THERM}}$ pull-up |
| EMC1182-1-AIA-TR | 8-pin DFN 3mm x 3mm (RoHS compliant) | Two temperature sensors, $\overline{\text{ALERT/THERM2}}$ and $\overline{\text{THERM}}$ pins, fixed SMBus address | 1001_100(r/w) |
| EMC1182-1-AC3-TR | 8-pin TDFN 2mm x 3mm (RoHS compliant) | Two temperature sensors, $\overline{\text{ALERT/THERM2}}$ and $\overline{\text{THERM}}$ pins, fixed SMBus address | 1001_100(r/w) |
| EMC1182-2-AIA-TR | 8-pin DFN 3mm x 3mm (RoHS compliant) | Two temperature sensors, $\overline{\text{ALERT/THERM2}}$ and $\overline{\text{THERM}}$ pins, fixed SMBus address | 1001_101(r/w) |
| EMC1182-2-AC3-TR | 8-pin TDFN 2mm x 3mm (RoHS compliant) | Two temperature sensors, $\overline{\text{ALERT/THERM2}}$ and $\overline{\text{THERM}}$ pins, fixed SMBus address | 1001_101(r/w) |

This product meets the halogen maximum concentration values per IEC61249-2-21

For RoHS compliance and environmental information, please visit www.smSC.com/rohs

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Chapter 1 Block Diagram

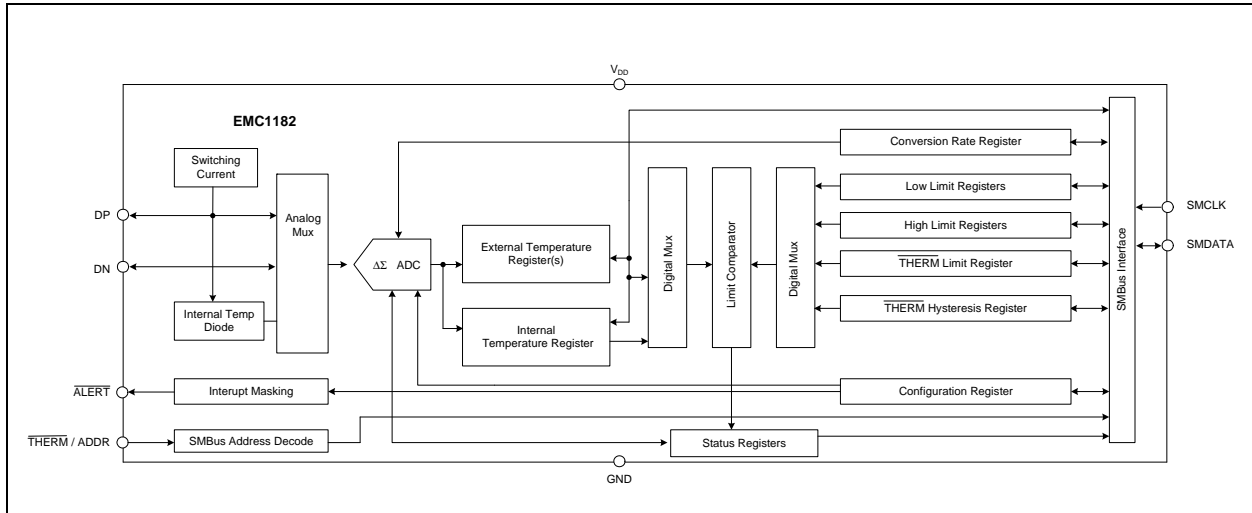


Figure 1.1 EMC1182 Block Diagram

Chapter 2 Pin Description

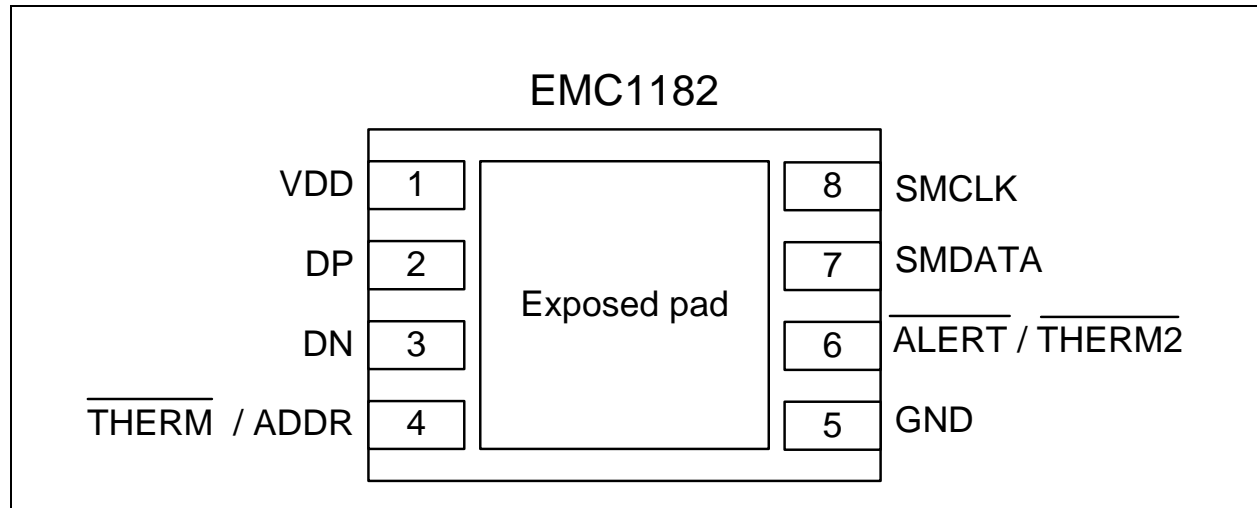


Figure 2.1 EMC1182 Pin Diagram, TDFN-8 2mm x 3mm / DFN-8 3mm x 3mm

Table 2.1 EMC1182 Pin Description

| PIN NUMBER | NAME | FUNCTION | TYPE |
|------------|--|---|-----------|
| 1 | VDD | Power supply | Power |
| 2 | DP | External diode positive (anode) connection | AIO |
| 3 | DN | External diode negative (cathode) connection | AIO |
| 4 | $\overline{\text{THERM}} / \text{ADDR}$ | $\overline{\text{THERM}}$ - Active low Critical $\overline{\text{THERM}}$ output signal - requires pull-up resistor | OD (5V) |
| | | ADDR - Selects SMBus address based on pull-up resistor | OD (5V) |
| 5 | GND | Ground | Power |
| 6 | $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ | Active low digital $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ output signal - requires pull-up resistor | OD (5V) |
| 7 | SMDATA | SMBus Data input/output - requires pull-up resistor | DIOD (5V) |
| 8 | SMCLK | SMBus Clock input - requires pull-up resistor | DI (5V) |
| Bottom Pad | Exposed Pad | Not internally connected, but recommend grounding. | - |

The pin types are described [Table 2.2](#).

Table 2.2 Pin Types

| PIN TYPE | DESCRIPTION |
|-----------------|---|
| Power | This pin is used to supply power or ground to the device. |
| AIO | Analog Input / Output -This pin is used as an I/O for analog signals. |
| DI | Digital Input - This pin is used as a digital input. This pin is 5V tolerant. |
| DIOD | Digital Input / Open Drain Output - This pin is used as a digital I/O. When it is used as an output, it is open drain and requires a pull-up resistor. This pin is 5V tolerant. |
| OD | Open Drain Digital Output - This pin is used as a digital output. It is open drain and requires a pull-up resistor. This pin is 5V tolerant. |

Chapter 3 Electrical Specifications

3.1 Absolute Maximum Ratings

Table 3.1 Absolute Maximum Ratings

| DESCRIPTION | RATING | UNIT |
|---|--------------------------------|------|
| Supply Voltage (V_{DD}) | -0.3 to 4.0 | V |
| Voltage on 5V tolerant pins (V_{5VT_pin}) | -0.3 to 5.5 | V |
| Voltage on 5V tolerant pins ($(V_{5VT_pin} - V_{DD})$) (see Note 3.1) | 0 to 3.6 | V |
| Voltage on any other pin to Ground | -0.3 to $V_{DD} + 0.3$ | V |
| Operating Temperature Range | -40 to +125 | °C |
| Storage Temperature Range | -55 to +150 | °C |
| Lead Temperature Range | Refer to JEDEC Spec. J-STD-020 | |
| Package Thermal Characteristics for TDFN-8 | | |
| Thermal Resistance (θ_{j-a}) | 89 | °C/W |
| ESD Rating, All pins HBM | 2000 | V |

Note: Stresses at or above those listed could cause permanent damage to the device. This is a stress rating only and functional operation of the device at any other condition above those indicated in the operation sections of this specification is not implied.

Note 3.1 For the 5V tolerant pins that have a pull-up resistor (\overline{SMCLK} , \overline{SMDATA} , $\overline{THERM1}$, and $\overline{ALERT} / \overline{THERM2}$), the pull-up voltage must not exceed 3.6V when the device is unpowered.

3.2 Electrical Specifications

Table 3.2 Electrical Specifications

| $V_{DD} = 3.0V$ to $3.6V$, $T_A = -40^\circ C$ to $125^\circ C$, all typical values at $T_A = 27^\circ C$ unless otherwise noted. | | | | | | |
|---|----------|-----|-----|-----|---------|---|
| CHARACTERISTIC | SYMBOL | MIN | TYP | MAX | UNITS | CONDITIONS |
| DC Power | | | | | | |
| Supply Voltage | V_{DD} | 3.0 | 3.3 | 3.6 | V | |
| Supply Current | I_{DD} | | 200 | 410 | μA | 0.0625 conversion / sec, dynamic averaging disabled |
| | | | 215 | 425 | μA | 1 conversion / sec, dynamic averaging disabled |

Table 3.2 Electrical Specifications (continued)

| V _{DD} = 3.0V to 3.6V, T _A = -40°C to 125°C, all typical values at T _A = 27°C unless otherwise noted. | | | | | | |
|--|---------------------|-----|-------|------|-------|---|
| CHARACTERISTIC | SYMBOL | MIN | TYP | MAX | UNITS | CONDITIONS |
| | | | 325 | 465 | μA | 4 conversions / sec, dynamic averaging disabled |
| | | | 890 | 1050 | μA | 4 conversions / sec, dynamic averaging enabled |
| | | | 1120 | | μA | ≥ 16 conversions / sec, dynamic averaging enabled |
| Standby Supply Current | I _{DD} | | 170 | 230 | μA | Device in Standby mode, no SMBus communications, ALERT and THERM pins not asserted. |
| Internal Temperature Monitor | | | | | | |
| Temperature Accuracy | | | ±0.25 | ±1 | °C | -5°C < T _A < 100°C |
| | | | | ±2 | °C | -40°C < T _A < 125°C |
| Temperature Resolution | | | 0.125 | | °C | |
| External Temperature Monitor | | | | | | |
| Temperature Accuracy | | | ±0.25 | ±1 | °C | +20°C < T _{DIODE} < +110°C 0°C < T _A < 100°C |
| | | | | ±0.5 | ±2 | °C |
| Temperature Resolution | | | 0.125 | | °C | |
| Conversion Time all Channels | t _{CONV} | | 190 | | ms | default settings |
| Capacitive Filter | C _{FILTER} | | 2.2 | 2.7 | nF | Connected across external diode |
| $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ and $\overline{\text{THERM}}$ pins | | | | | | |
| Output Low Voltage | V _{OL} | 0.4 | | | V | I _{SINK} = 8mA |
| Leakage Current | I _{LEAK} | | | ±5 | μA | $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ and $\overline{\text{SYS_SHDN}}$ pins Device powered or unpowered T _A < 85°C pull-up voltage ≤ 3.6V |

3.3 SMBus Electrical Characteristics

Table 3.3 SMBus Electrical Specifications

| V _{DD} = 3.0 to 3.6V, T _A = -40°C to 125°C, all typical values are at T _A = 27°C unless otherwise noted. | | | | | | |
|---|----------------------|------|-----|-----------------|-------|--|
| CHARACTERISTIC | SYMBOL | MIN | TYP | MAX | UNITS | CONDITIONS |
| SMBus Interface | | | | | | |
| Input High Voltage | V _{IH} | 1.4 | | V _{DD} | V | 5V Tolerant. Voltage threshold based on 1.8V operation |
| Input Low Voltage | V _{IL} | -0.3 | | 0.8 | V | 5V Tolerant. Voltage threshold based on 1.8V operation |
| Leakage Current | I _{LEAK} | | | ±5 | µA | Powered or unpowered T _A < 85°C |
| Hysteresis | | 50 | | | mV | |
| Input Capacitance | C _{IN} | | 5 | | pF | |
| Output Low Sink Current | I _{OL} | 8.2 | | 15 | mA | SMDATA = 0.4V |
| SMBus Timing | | | | | | |
| Clock Frequency | f _{SMB} | 10 | | 400 | kHz | |
| Spike Suppression | t _{SP} | | | 50 | ns | |
| Bus Free Time Stop to Start | t _{BUF} | 1.3 | | | µs | |
| Hold Time: Start | t _{HD:STA} | 0.6 | | | µs | |
| Setup Time: Start | t _{SU:STA} | 0.6 | | | µs | |
| Setup Time: Stop | t _{SU:STO} | 0.6 | | | µs | |
| Data Hold Time | t _{HD:DAT} | 0 | | | µs | When transmitting to the master |
| Data Hold Time | t _{HD:DAT} | 0.3 | | | µs | When receiving from the master |
| Data Setup Time | t _{SU:DAT} | 100 | | | ns | |
| Clock Low Period | t _{LOW} | 1.3 | | | µs | |
| Clock High Period | t _{HIGH} | 0.6 | | | µs | |
| Clock/Data Fall time | t _{FALL} | | | 300 | ns | Min = 20+0.1C _{LOAD} ns |
| Clock/Data Rise time | t _{RISE} | | | 300 | ns | Min = 20+0.1C _{LOAD} ns |
| Capacitive Load | C _{LOAD} | | | 400 | pF | per bus line |
| Timeout | t _{TIMEOUT} | 25 | | 35 | ms | Disabled by default |

Chapter 4 System Management Bus Interface Protocol

4.1 Communications Protocol

The EMC1182 communicates with a host controller, such as an SMSC SIO, through the SMBus. The SMBus is a two-wire serial communication protocol between a computer host and its peripheral devices. A detailed timing diagram is shown in [Figure 4.1](#).

For the first 15ms after power-up the device may not respond to SMBus communications.

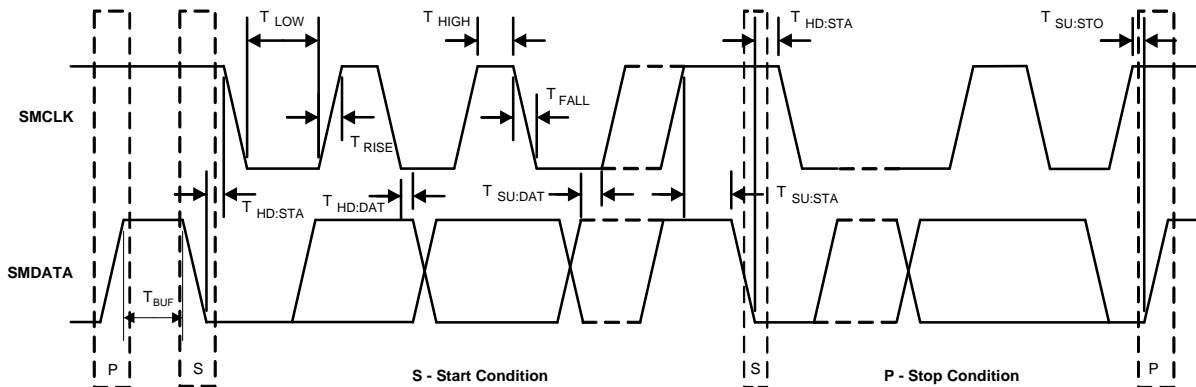


Figure 4.1 SMBus Timing Diagram

4.1.1 SMBus Start Bit

The SMBus Start bit is defined as a transition of the SMBus Data line from a logic '1' state to a logic '0' state while the SMBus Clock line is in a logic '1' state.

4.1.2 SMBus Address and $\overline{RD/WR}$ Bit

The SMBus Address Byte consists of the 7-bit client address followed by the $\overline{RD/WR}$ indicator bit. If this $\overline{RD/WR}$ bit is a logic '0', the SMBus Host is writing data to the client device. If this $\overline{RD/WR}$ bit is a logic '1', the SMBus Host is reading data from the client device.

The EMC1182-A SMBus slave address is determined by the pull-up resistor on the \overline{THERM} pin as shown in [Table 4.1](#), "[SMBus Address Decode](#)".

The Address decode is performed by pulling known currents from VDD through the external resistor causing the pin voltage to drop based on the respective current / resistor relationship. This pin voltage is compared against a threshold that determines the value of the pull-up resistor.

Table 4.1 SMBus Address Decode

| PULL UP RESISTOR ON THERM PIN ($\pm 5\%$) | SMBUS ADDRESS |
|---|----------------|
| 4.7k | 1111_100(r/w)b |
| 6.8k | 1011_100(r/w)b |

Table 4.1 SMBus Address Decode (continued)

| PULL UP RESISTOR ON THERM PIN ($\pm 5\%$) | SMBUS ADDRESS |
|---|----------------|
| 10k | 1001_100(r/w)b |
| 15k | 1101_100(r/w)b |
| 22k | 0011_100(r/w)b |
| 33k | 0111_100(r/w)b |

The EMC1182-1 SMBus address is hard coded to 1001_100(r/w).

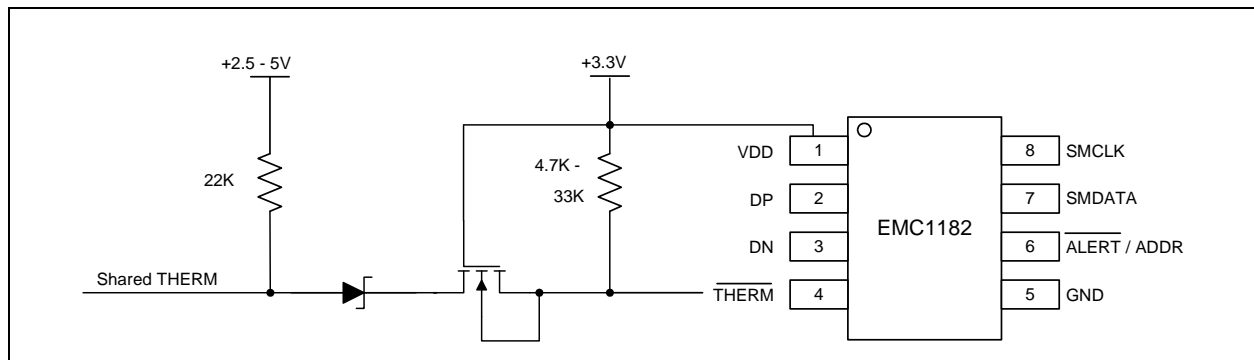
The EMC1182-2 SMBus address is hard coded to 1001_101(r/w).

4.1.3 THERM Pin Considerations

Because of the decode method used to determine the SMBus Address, it is important that the pull-up resistance on the THERM pin be within the tolerances shown in Table 4.1. Additionally, the pull-up resistor on the THERM pin must be connected to the same 3.3V supply that drives the VDD pin.

For 15ms after power up, the THERM pin must not be pulled low or the SMBus address will not be decoded properly. If the system requirements do not permit these conditions, the THERM pin must be isolated from its hard-wired OR'd bus during this time.

One method of isolating this pin is shown in Figure 4.4, "Isolating the THERM pin".

**Figure 4.4 Isolating the THERM pin**

4.1.5 SMBus Data Bytes

All SMBus Data bytes are sent most significant bit first and composed of 8-bits of information.

4.1.6 SMBus ACK and NACK Bits

The SMBus client will acknowledge all data bytes that it receives. This is done by the client device pulling the SMBus data line low after the 8th bit of each byte that is transmitted. This applies to the Write Byte protocol.

The Host will NACK (not acknowledge) the last data byte to be received from the client by holding the SMBus data line high after the 8th data bit has been sent.

4.1.7 SMBus Stop Bit

The SMBus Stop bit is defined as a transition of the SMBus Data line from a logic '0' state to a logic '1' state while the SMBus clock line is in a logic '1' state. When the device detects an SMBus Stop bit and it has been communicating with the SMBus protocol, it will reset its client interface and prepare to receive further communications.

4.1.8 SMBus Timeout

The EMC1182 supports SMBus Timeout. If the clock line is held low for longer than t_{TIMEOUT} , the device will reset its SMBus protocol. This function can be enabled by setting the TIMEOUT bit (see [Section 6.11, "Consecutive ALERT Register 22h"](#)).

4.1.9 SMBus and I²C Compatibility

The EMC1182 is compatible with SMBus and I²C. The major differences between SMBus and I²C devices are highlighted here. For more information, refer to the SMBus 2.0 and I²C specifications. For information on using the EMC1182 in an I²C system, refer to SMSC AN 14.0 SMSC Dedicated Slave Devices in I²C Systems.

1. EMC1182 supports I²C fast mode at 400kHz. This covers the SMBus max time of 100kHz.
2. Minimum frequency for SMBus communications is 10kHz.
3. The SMBus client protocol will reset if the clock is held at a logic '0' for longer than 30ms. This timeout functionality is disabled by default in the EMC1182 and can be enabled by writing to the TIMEOUT bit. I²C does not have a timeout.
4. I²C devices do not support the Alert Response Address functionality (which is optional for SMBus).

Attempting to communicate with the EMC1182 SMBus interface with an invalid slave address or invalid protocol will result in no response from the device and will not affect its register contents. Stretching of the SMCLK signal is supported, provided other devices on the SMBus control the timing.

4.2 SMBus Protocols

The device supports Send Byte, Read Byte, Write Byte, Receive Byte, and the Alert Response Address as valid protocols as shown below.

All of the below protocols use the convention in [Table 4.1](#).

Table 4.1 Protocol Format

| DATA SENT TO DEVICE | DATA SENT TO THE HOST |
|---------------------|-----------------------|
| # of bits sent | # of bits sent |

4.2.1 Write Byte

The Write Byte is used to write one byte of data to the registers, as shown in [Table 4.2](#).

Table 4.2 Write Byte Protocol

| START | SLAVE ADDRESS | WR | ACK | REGISTER ADDRESS | ACK | REGISTER DATA | ACK | STOP |
|--------|---------------|----|-----|------------------|-----|---------------|-----|--------|
| 1 -> 0 | YYYY_YYY | 0 | 0 | XXh | 0 | XXh | 0 | 0 -> 1 |

4.2.2 Read Byte

The Read Byte protocol is used to read one byte of data from the registers as shown in [Table 4.3](#).

Table 4.3 Read Byte Protocol

| START | SLAVE ADDRESS | WR | ACK | REGISTER ADDRESS | ACK | START | SLAVE ADDRESS | RD | ACK | REGISTER DATA | NACK | STOP |
|--------|---------------|----|-----|------------------|-----|--------|---------------|----|-----|---------------|------|--------|
| 1 -> 0 | YYYY_YYY | 0 | 0 | XXh | 0 | 1 -> 0 | YYYY_YYY | 1 | 0 | XX | 1 | 0 -> 1 |

4.2.3 Send Byte

The Send Byte protocol is used to set the internal address register pointer to the correct address location. No data is transferred during the Send Byte protocol as shown in [Table 4.4](#).

Table 4.4 Send Byte Protocol

| START | SLAVE ADDRESS | WR | ACK | REGISTER ADDRESS | ACK | STOP |
|--------|---------------|----|-----|------------------|-----|--------|
| 1 -> 0 | YYYY_YYY | 0 | 0 | XXh | 0 | 0 -> 1 |

4.2.4 Receive Byte

The Receive Byte protocol is used to read data from a register when the internal register address pointer is known to be at the right location (e.g. set via Send Byte). This is used for consecutive reads of the same register as shown in [Table 4.5](#).

Table 4.5 Receive Byte Protocol

| START | SLAVE ADDRESS | RD | ACK | REGISTER DATA | NACK | STOP |
|--------|---------------|----|-----|---------------|------|--------|
| 1 -> 0 | YYYY_YYY | 1 | 0 | XXh | 1 | 0 -> 1 |

4.3 Alert Response Address

The $\overline{\text{ALERT}}$ output can be used as a processor interrupt or as an SMBus Alert.

When it detects that the $\overline{\text{ALERT}}$ pin is asserted, the host will send the Alert Response Address (ARA) to the general address of 0001_100xb. All devices with active interrupts will respond with their client address as shown in [Table 4.6](#).

Table 4.6 Alert Response Address Protocol

| START | ALERT RESPONSE ADDRESS | RD | ACK | DEVICE ADDRESS | NACK | STOP |
|--------|------------------------|----|-----|----------------|------|--------|
| 1 -> 0 | 0001_100 | 1 | 0 | YYYY_YYY | 1 | 0 -> 1 |

The EMC1182 will respond to the ARA in the following way:

1. Send Slave Address and verify that full slave address was sent (i.e. the SMBus communication from the device was not prematurely stopped due to a bus contention event).
2. Set the MASK_ALL bit to clear the $\overline{\text{ALERT}}$ pin.

APPLICATION NOTE: The ARA does not clear the Status Register and if the MASK_ALL bit is cleared prior to the Status Register being cleared, the $\overline{\text{ALERT}}$ pin will be reasserted.

Chapter 5 Product Description

The is an SMBus temperature sensor. The EMC1182 monitors one internal diode and one externally connected temperature diode.

Thermal management is performed in cooperation with a host device. This consists of the host reading the temperature data of both the external and internal temperature diodes of the EMC1182 and using that data to control the speed of one or more fans.

The EMC1182 has two levels of monitoring. The first provides a maskable $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ signal to the host when the measured temperatures exceeds user programmable limits. This allows the EMC1182 to be used as an independent thermal watchdog to warn the host of temperature hot spots without direct control by the host. The second level of monitoring provides a non-maskable interrupt on the $\overline{\text{THERM}}$ pin if the measured temperatures meet or exceed a second programmable limit.

Figure 5.1 shows a system level block diagram of the EMC1182.

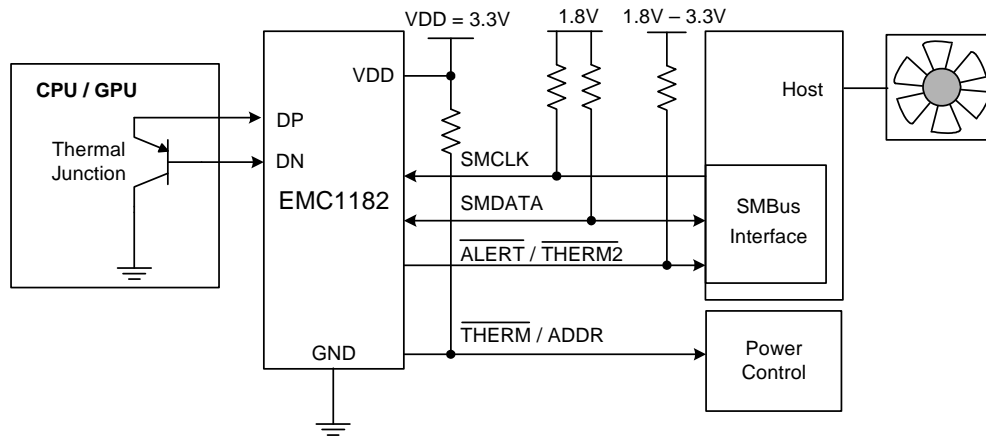


Figure 5.1 System Diagram for EMC1182

5.1 Modes of Operation

The EMC1182 has two modes of operation.

- Active (Run) - In this mode of operation, the ADC is converting on all temperature channels at the programmed conversion rate. The temperature data is updated at the end of every conversion and the limits are checked. In Active mode, writing to the one-shot register will do nothing.
- Standby (Stop) - In this mode of operation, the majority of circuitry is powered down to reduce supply current. The temperature data is not updated and the limits are not checked. In this mode of operation, the SMBus is fully active and the part will return requested data. Writing to the one-shot register will enable the device to update all temperature channels. Once all the channels are updated, the device will return to the Standby mode.

5.2 Conversion Rates

The EMC1182 may be configured for different conversion rates based on the system requirements. The conversion rate is configured as described in [Section 6.5](#). The default conversion rate is 4 conversions per second. Other available conversion rates are shown in [Table 6.6, "Conversion Rate"](#).

5.3 Dynamic Averaging

Dynamic averaging causes the EMC1182 to measure the external diode channels for an extended time based on the selected conversion rate. This functionality can be disabled for increased power savings at the lower conversion rates (see [Section 6.4, "Configuration Register 03h / 09h"](#)). When dynamic averaging is enabled, the device will automatically adjust the sampling and measurement time for the external diode channels. This allows the device to average 2x or 16x longer than the normal 11 bit operation (nominally 21ms per channel) while still maintaining the selected conversion rate. The benefits of dynamic averaging are improved noise rejection due to the longer integration time as well as less random variation of the temperature measurement.

When enabled, the dynamic averaging applies when a one-shot command is issued. The device will perform the desired averaging during the one-shot operation according to the selected conversion rate.

When enabled, the dynamic averaging will affect the average supply current based on the chosen conversion rate as shown in [Table 5.1](#).

Table 5.1 Supply Current vs. Conversion Rate for EMC1182

| CONVERSION RATE | AVERAGE SUPPLY CURRENT (TYPICAL) | | AVERAGING FACTOR (BASED ON 11-BIT OPERATION) | |
|-------------------|----------------------------------|----------|--|----------|
| | ENABLED (DEFAULT) | DISABLED | ENABLED (DEFAULT) | DISABLED |
| 1 / 16 sec | 210uA | 200uA | 16x | 1x |
| 1 / 8 sec | 265uA | 200uA | 16x | 1x |
| 1 / 4 sec | 330uA | 200uA | 16x | 1x |
| 1 / 2 sec | 395uA | 200uA | 16x | 1x |
| 1 / sec | 460uA | 215uA | 16x | 1x |
| 4 / sec (default) | 890uA | 325uA | 8x | 1x |
| 8 / sec | 1010uA | 630uA | 4x | 1x |
| 16 / sec | 1120uA | 775uA | 2x | 1x |
| 32 / sec | 1200uA | 1050uA | 1x | 1x |
| 64 / sec | 1400uA | 1100uA | 0.5x | 0.5x |

5.4 THERM Output

The $\overline{\text{THERM}}$ output is asserted independently of the $\overline{\text{ALERT}}$ output and cannot be masked. Whenever any of the measured temperatures exceed the user programmed Therm Limit values for the programmed number of consecutive measurements, the THERM output is asserted. Once it has been asserted, it will remain asserted until all measured temperatures drop below the Therm Limit minus the Therm Hysteresis (also programmable).

When the $\overline{\text{THERM}}$ pin is asserted, the THERM status bits will likewise be set. Reading these bits will not clear them until the $\overline{\text{THERM}}$ pin is deasserted. Once the $\overline{\text{THERM}}$ pin is deasserted, the THERM status bits will be automatically cleared.

5.4.1 $\overline{\text{THERM}}$ Pin Considerations

Because of the decode method used to determine the SMBus Address, it is important that the pull-up resistance on $\overline{\text{THERM}}$ pin be within $\pm 10\%$ tolerance. Additionally, the pull-up resistor on the $\overline{\text{THERM}}$ pin must be connected to the same 3.3V supply that drives the VDD pin.

For 15ms after power up, the $\overline{\text{THERM}}$ pin must not be pulled low or the SMBus Address will not be decoded properly. If the system requirements do not permit these conditions, the $\overline{\text{THERM}}$ pin must be isolated from the bus during this time. One method of isolating this pin is shown in [Figure 5.2](#).

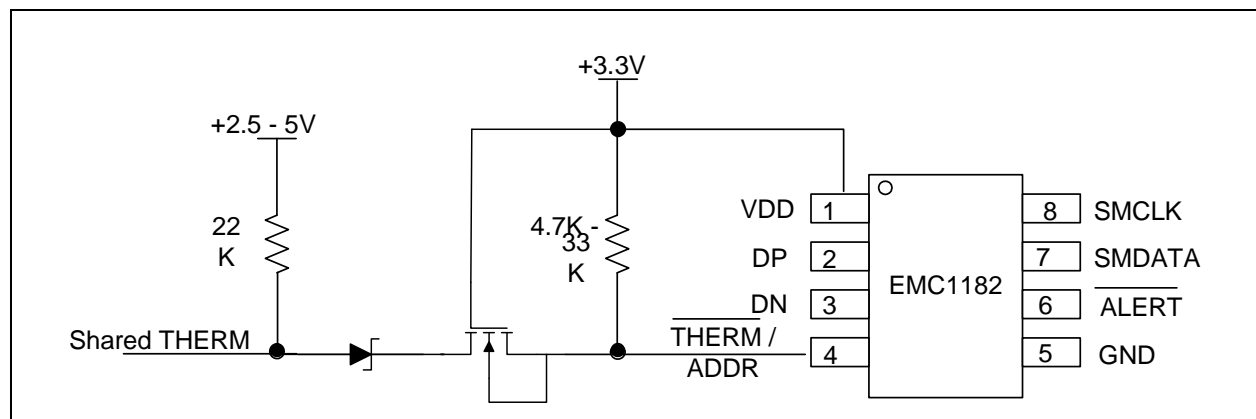


Figure 5.2 Isolating $\overline{\text{THERM}}$ Pin

5.5 $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ Output

The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is an open drain output and requires a pull-up resistor to V_{DD} and has two modes of operation: interrupt mode and comparator mode. The mode of the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ output is selected via the ALERT / COMPALERT/THERM bit in the Configuration Register (see [Section 6.4](#)).

5.5.1 $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ Pin Interrupt $\overline{\text{ALERT}}$ Mode

When configured to operate in interrupt mode, the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin asserts low when an out of limit measurement (\geq high limit or $<$ low limit) is detected on any diode or when a diode fault is detected, functioning as any standard ALERT in on the SMBus. The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will remain asserted as long as an out-of-limit condition remains. Once the out-of-limit condition has been removed, the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will remain asserted until the appropriate status bits are cleared.

The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin can be masked by setting the MASK_ALL bit. Once the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin has been masked, it will be de-asserted and remain de-asserted until the MASK_ALL bit is cleared by the user. Any interrupt conditions that occur while the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is masked will update the Status Register normally. There are also individual channel masks (see [Section 6.10](#)).

The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is used as an interrupt signal or as an SMBus Alert signal that allows an SMBus slave to communicate an error condition to the master. One or more $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ outputs can be hard-wired together.

5.5.2 $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ Pin Comparator THERM Mode

When the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is configured to operate in comparator mode, it will be asserted if any of the measured temperatures exceeds the respective high limit, acting as a second THERM function

in. The $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ pin will remain asserted until all temperatures drop below the corresponding high limit minus the Therm Hysteresis value.

When the $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ pin is asserted in comparator mode, the corresponding high limit status bits will be set. Reading these bits will not clear them until the $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ pin is deasserted. Once the $\overline{\text{ALERT}}$ pin is deasserted, the status bits will be automatically cleared.

The MASK_ALL bit will not block the $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ pin in this mode; however, the individual channel masks (see [Section 6.10](#)) will prevent the respective channel from asserting the $\overline{\text{ALERT}} / \overline{\text{THERM2}}$ pin.

5.6 Temperature Measurement

The EMC1182 can monitor the temperature of one externally connected diode.

The device contains programmable High, Low, and Therm limits for all measured temperature channels. If the measured temperature goes below the Low limit or above the High limit, the $\overline{\text{ALERT}}$ pin can be asserted (based on user settings). If the measured temperature meets or exceeds the Therm Limit, the THERM pin is asserted unconditionally, providing two tiers of temperature detection.

5.6.1 Beta Compensation

The EMC1182 is configured to monitor the temperature of basic diodes (e.g., 2N3904) or CPU thermal diodes. For External Diode 1, it automatically detects the type of external diode (CPU diode or diode connected transistor) and determines the optimal setting to reduce temperature errors introduced by beta variation. Compensating for this error is also known as implementing the transistor or BJT model for temperature measurement.

For discrete transistors configured with the collector and base shorted together, the beta is generally sufficiently high such that the percent change in beta variation is very small. For example, a 10% variation in beta for two forced emitter currents with a transistor whose ideal beta is 50 would contribute approximately 0.25°C error at 100°C. However for substrate transistors where the base-emitter junction is used for temperature measurement and the collector is tied to the substrate, the proportional beta variation will cause large error. For example, a 10% variation in beta for two forced emitter currents with a transistor whose ideal beta is 0.5 would contribute approximately 8.25°C error at 100°C.

5.6.2 Resistance Error Correction (REC)

Parasitic resistance in series with the external diodes will limit the accuracy obtainable from temperature measurement devices. The voltage developed across this resistance by the switching diode currents cause the temperature measurement to read higher than the true temperature. Contributors to series resistance are PCB trace resistance, on die (i.e. on the processor) metal resistance, bulk resistance in the base and emitter of the temperature transistor. Typically, the error caused by series resistance is +0.7°C per ohm. The EMC1182 automatically corrects up to 100 ohms of series resistance.

5.6.3 Programmable External Diode Ideality Factor

The EMC1182 is designed for external diodes with an ideality factor of 1.008. Not all external diodes, processor or discrete, will have this exact value. This variation of the ideality factor introduces error in the temperature measurement which must be corrected for. This correction is typically done using programmable offset registers. Since an ideality factor mismatch introduces an error that is a function of temperature, this correction is only accurate within a small range of temperatures. To provide maximum flexibility to the user, the EMC1182 provides a 6-bit register for each external diode where the ideality factor of the diode used is programmed to eliminate errors across all temperatures.

APPLICATION NOTE: When monitoring a substrate transistor or CPU diode and beta compensation is enabled, the Ideality Factor should not be adjusted. Beta Compensation automatically corrects for most ideality errors.

5.7 Diode Faults

The EMC1182 detects an open on the DP and DN pins, and a short across the DP and DN pins. For each temperature measurement made, the device checks for a diode fault on the external diode channel(s). When a diode fault is detected, the ALERT / THERM2 pin asserts (unless masked, see [Section 5.8](#)) and the temperature data reads 00h in the MSB and LSB registers (note: the low limit will not be checked). A diode fault is defined as one of the following: an open between DP and DN, a short from V_{DD} to DP, or a short from V_{DD} to DN.

If a short occurs across DP and DN or a short occurs from DP to GND, the low limit status bit is set and the ALERT / THERM2 pin asserts (unless masked). This condition is indistinguishable from a temperature measurement of 0.000°C (-64°C in extended range) resulting in temperature data of 00h in the MSB and LSB registers.

If a short from DN to GND occurs (with a diode connected), temperature measurements will continue as normal with no alerts.

5.8 Consecutive Alerts

The EMC1182 contains multiple consecutive alert counters. One set of counters applies to the ALERT / THERM2 pin and the second set of counters applies to the THERM pin. Each temperature measurement channel has a separate consecutive alert counter for each of the ALERT / THERM2 and THERM pins. All counters are user programmable and determine the number of consecutive measurements that a temperature channel(s) must be out-of-limit or reporting a diode fault before the corresponding pin is asserted.

See [Section 6.11, "Consecutive ALERT Register 22h"](#) for more details on the consecutive alert function.

5.9 Digital Filter

To reduce the effect of noise and temperature spikes on the reported temperature, the External Diode channel uses a programmable digital filter. This filter can be configured as Level 1, Level 2, or Disabled (default) (see [Section 6.14](#)). The typical filter performance is shown in [Figure 5.4](#) and [Figure 5.5](#).



Figure 5.4 Temperature Filter Step Response

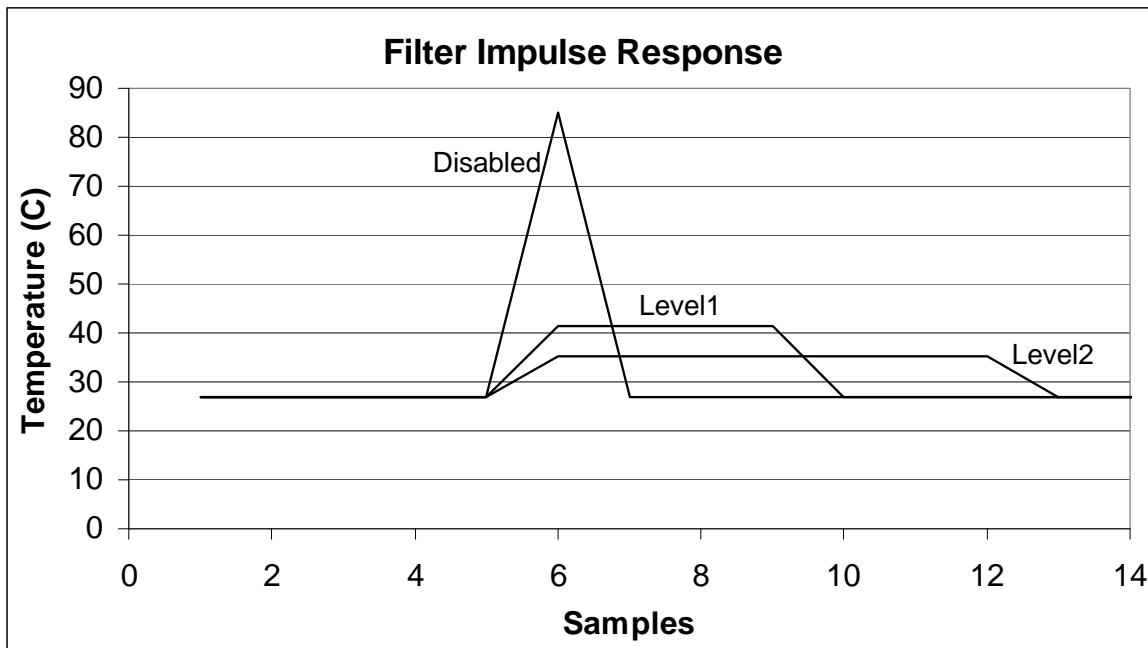


Figure 5.5 Temperature Filter Impulse Response

5.10 Temperature Measurement Results and Data

The temperature measurement results are stored in the internal and external temperature registers. These are then compared with the values stored in the high and low limit registers. Both external and internal temperature measurements are stored in 11-bit format with the eight (8) most significant bits stored in a high byte register and the three (3) least significant bits stored in the three (3) MSB positions of the low byte register. All other bits of the low byte register are set to zero.

The EMC1182 has two selectable temperature ranges. The default range is from 0°C to +127°C and the temperature is represented as binary number able to report a temperature from 0°C to +127.875°C in 0.125°C steps.

The extended range is an extended temperature range from -64°C to +191°C. The data format is a binary number offset by 64°C. The extended range is used to measure temperature diodes with a large known offset (such as AMD processor diodes) where the diode temperature plus the offset would be equivalent to a temperature higher than +127°C.

Table 5.2 shows the default and extended range formats.

Table 5.2 Temperature Data Format

| TEMPERATURE (°C) | DEFAULT RANGE 0°C TO 127°C | EXTENDED RANGE -64°C TO 191°C |
|------------------|----------------------------|-------------------------------|
| Diode Fault | 000 0000 0000 | 000 0000 0000 |
| -64 | 000 0000 0000 | 000 0000 0000 |
| -1 | 000 0000 0000 | 001 1111 1000 |
| 0 | 000 0000 0000 | 010 0000 0000 |
| 0.125 | 000 0000 0001 | 010 0000 0001 |
| 1 | 000 0000 1000 | 010 0000 1000 |
| 64 | 010 0000 0000 | 100 0000 0000 |
| 65 | 010 0000 1000 | 100 0000 1000 |
| 127 | 011 1111 1000 | 101 1111 1000 |
| 127.875 | 011 1111 1111 | 101 1111 1111 |
| 128 | 011 1111 1111 | 110 0000 0000 |
| 190 | 011 1111 1111 | 111 1111 0000 |
| 191 | 011 1111 1111 | 111 1111 1000 |
| >= 191.875 | 011 1111 1111 | 111 1111 1111 |

Chapter 6 Register Description

The registers shown in [Table 6.1](#) are accessible through the SMBus. An entry of '-' indicates that the bit is not used and will always read '0'.

Table 6.1 Register Set in Hexadecimal Order

| REGISTER ADDRESS | R/W | REGISTER NAME | FUNCTION | DEFAULT VALUE | PAGE |
|------------------|-----|-------------------------------------|--|---------------|---------|
| 00h | R | Internal Diode Data High Byte | Stores the integer data for the Internal Diode | 00h | Page 27 |
| 01h | R | External Diode Data High Byte | Stores the integer data for the External Diode | 00h | |
| 02h | R-C | Status | Stores status bits for the Internal Diode and External Diode | 00h | Page 28 |
| 03h | R/W | Configuration | Controls the general operation of the device (mirrored at address 09h) | 00h | Page 28 |
| 04h | R/W | Conversion Rate | Controls the conversion rate for updating temperature data (mirrored at address 0Ah) | 06h (4/sec) | Page 29 |
| 05h | R/W | Internal Diode High Limit | Stores the 8-bit high limit for the Internal Diode (mirrored at address 0Bh) | 55h (85°C) | Page 30 |
| 06h | R/W | Internal Diode Low Limit | Stores the 8-bit low limit for the Internal Diode (mirrored at address 0Ch) | 00h (0°C) | |
| 07h | R/W | External Diode High Limit High Byte | Stores the integer portion of the high limit for the External Diode (mirrored at register 0Dh) | 55h (85°C) | |
| 08h | R/W | External Diode Low Limit High Byte | Stores the integer portion of the low limit for the External Diode (mirrored at register 0Eh) | 00h (0°C) | |
| 09h | R/W | Configuration | Controls the general operation of the device (mirrored at address 03h) | 00h | Page 28 |
| 0Ah | R/W | Conversion Rate | Controls the conversion rate for updating temperature data (mirrored at address 04h) | 06h (4/sec) | Page 29 |

Table 6.1 Register Set in Hexadecimal Order (continued)

| REGISTER ADDRESS | R/W | REGISTER NAME | FUNCTION | DEFAULT VALUE | PAGE |
|------------------|-----|-------------------------------------|--|---------------|---------|
| 0Bh | R/W | Internal Diode High Limit | Stores the 8-bit high limit for the Internal Diode (mirrored at address 05h) | 55h (85°C) | Page 30 |
| 0Ch | R/W | Internal Diode Low Limit | Stores the 8-bit low limit for the Internal Diode (mirrored at address 06h) | 00h (0°C) | |
| 0Dh | R/W | External Diode High Limit High Byte | Stores the integer portion of the high limit for the External Diode (mirrored at register 07h) | 55h (85°C) | |
| 0Eh | R/W | External Diode Low Limit High Byte | Stores the integer portion of the low limit for the External Diode (mirrored at register 08h) | 00h (0°C) | |
| 0Fh | W | One Shot | A write to this register initiates a one shot update. | 00h | Page 31 |
| 10h | R | External Diode Data Low Byte | Stores the fractional data for the External Diode | 00h | Page 27 |
| 11h | R/W | Scratchpad | Scratchpad register for software compatibility | 00h | Page 31 |
| 12h | R/W | Scratchpad | Scratchpad register for software compatibility | 00h | Page 31 |
| 13h | R/W | External Diode High Limit Low Byte | Stores the fractional portion of the high limit for the External Diode | 00h | Page 30 |
| 14h | R/W | External Diode Low Limit Low Byte | Stores the fractional portion of the low limit for the External Diode | 00h | |
| 19h | R/W | External Diode Therm Limit | Stores the 8-bit critical temperature limit for the External Diode | 55h (85°C) | Page 32 |
| 1Fh | R/W | Channel Mask Register | Controls the masking of individual channels | 00h | Page 32 |
| 20h | R/W | Internal Diode Therm Limit | Stores the 8-bit critical temperature limit for the Internal Diode | 55h (85°C) | Page 32 |
| 21h | R/W | Therm Hysteresis | Stores the 8-bit hysteresis value that applies to all Therm limits | 0Ah (10°C) | |
| 22h | R/W | Consecutive ALERT | Controls the number of out-of-limit conditions that must occur before an interrupt is asserted | 70h | Page 33 |
| 25h | R/W | External Diode1 Beta Configuration | Stores the Beta Compensation circuitry settings for External Diode1 | 08h | Page 35 |
| 27h | R/W | External Diode Ideality Factor | Stores the ideality factor for the External Diode | 12h (1.008) | Page 35 |

Table 6.1 Register Set in Hexadecimal Order (continued)

| REGISTER ADDRESS | R/W | REGISTER NAME | FUNCTION | DEFAULT VALUE | PAGE |
|------------------|-----|------------------------------|--|---------------|-------------------------|
| 29h | R | Internal Diode Data Low Byte | Stores the fractional data for the Internal Diode | 00h | Page 27 |
| 40h | R/W | Filter Control | Controls the digital filter setting for the External Diode channel | 00h | Page 37 |
| FDh | R | Product ID | Stores a fixed value that identifies the device | 20h | Page 37 |
| FEh | R | Manufacturer ID | Stores a fixed value that represents SMSC | 5Dh | Page 37 |
| FFh | R | Revision | Stores a fixed value that represents the revision number | 07h | Page 38 |

6.1 Data Read Interlock

When any temperature channel high byte register is read, the corresponding low byte is copied into an internal 'shadow' register. The user is free to read the low byte at any time and be guaranteed that it will correspond to the previously read high byte. Regardless if the low byte is read or not, reading from the same high byte register again will automatically refresh this stored low byte data.

6.2 Temperature Data Registers

Table 6.2 Temperature Data Registers

| ADDR | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|------|-----|--------------------------|-----|------|-------|----|----|----|----|----|---------|
| 00h | R | Internal Diode High Byte | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 00h |
| 29h | R | Internal Diode Low Byte | 0.5 | 0.25 | 0.125 | - | - | - | - | - | 00h |
| 01h | R | External Diode High Byte | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 00h |
| 10h | R | External Diode Low Byte | 0.5 | 0.25 | 0.125 | - | - | - | - | - | 00h |

As shown in [Table 6.2](#), all temperatures are stored as an 11-bit value with the high byte representing the integer value and the low byte representing the fractional value left justified to occupy the MSBits.

6.3 Status Register 02h

Table 6.3 Status Register

| ADDR | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|------|-----|----------|------|-------|------|-------|------|-------|--------|--------|---------|
| 02h | R-C | Status | BUSY | IHIGH | ILOW | EHIGH | ELOW | FAULT | ETHERM | ITHERM | 00h |

The Status Register reports the operating status of the Internal Diode and External Diode channels. When any of the bits are set (excluding the BUSY bit) either the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ or $\overline{\text{THERM}}$ pin is being asserted.

The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ and $\overline{\text{THERM}}$ pins are controlled by the respective consecutive alert counters (see Section 6.11) and will not be asserted until the programmed consecutive alert count has been reached. The status bits (except ETHERM and ITHERM) will remain set until read unless the $\overline{\text{ALERT}}$ pin is configured as a second $\overline{\text{THERM}}$ output (see Section 5.4).

Bit 7 - BUSY - This bit indicates that the ADC is currently converting. This bit does not cause either the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ or $\overline{\text{THERM}}$ pin to be asserted.

Bit 6 - IHIGH - This bit is set when the Internal Diode channel exceeds its programmed high limit. When set, this bit will assert the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin.

Bit 5 - ILOW - This bit is set when the Internal Diode channel drops below its programmed low limit. When set, this bit will assert the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin.

Bit 4 - EHIGH - This bit is set when the External Diode channel exceeds its programmed high limit. When set, this bit will assert the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin.

Bit 3 - ELOW - This bit is set when the External Diode channel drops below its programmed low limit. When set, this bit will assert the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin.

Bit 2 - FAULT - This bit is asserted when a diode fault is detected. When set, this bit will assert the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin.

Bit 1 - ETHERM - This bit is set when the External Diode channel exceeds the programmed Therm Limit. When set, this bit will assert the $\overline{\text{THERM}}$ pin. This bit will remain set until the $\overline{\text{THERM}}$ pin is released at which point it will be automatically cleared.

Bit 0 - ITHERM - This bit is set when the Internal Diode channel exceeds the programmed Therm Limit. When set, this bit will assert the $\overline{\text{THERM}}$ pin. This bit will remain set until the $\overline{\text{THERM}}$ pin is released at which point it will be automatically cleared.

6.4 Configuration Register 03h / 09h

Table 6.4 Configuration Register

| ADDR | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|------|-----|---------------|-----------|-----------|---|------|----|-------|-----------|----|---------|
| 03h | R/W | Configuration | MASK_ ALL | RUN/ STOP | $\overline{\text{ALERT}}/ \overline{\text{THERM2}}$ | RECD | - | RANGE | DAVG_ DIS | - | 00h |
| 09h | | | | | | | | | | | |

The Configuration Register controls the basic operation of the device. This register is fully accessible at either address.

Bit 7 - MASK_ALL - Masks the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin from asserting.

- '0' - (default) - The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is not masked. If any of the appropriate status bits are set the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will be asserted.
- '1' - The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is masked. It will not be asserted for any interrupt condition unless it is configured in comparator mode. The Status Registers will be updated normally.

Bit 6 - RUN / STOP - Controls Active/Standby modes.

- '0' (default) - The device is in Active mode and converting on all channels.
- '1' - The device is in Standby mode and not converting.

Bit 5 - $\overline{\text{ALERT}}/\overline{\text{THERM2}}$ - Controls the operation of the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin.

- '0' (default) - The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ acts as an Alert pin and has interrupt behavior as described in [Section 5.5.1](#).
- '1' - The $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ acts as a THERM pin and has comparator behavior as described in [Section 5.5.2](#). In this mode the MASK_ALL bit is ignored.

Bit 4 - RECD - Disables the Resistance Error Correction (REC) for the External Diode.

- '0' (default) - REC is enabled for the External Diode.
- '1' - REC is disabled for the External Diode.

Bit 2 - RANGE - Configures the measurement range and data format of the temperature channels.

- '0' (default) - The temperature measurement range is 0°C to +127.875°C and the data format is binary.
- '1' - The temperature measurement range is -64°C to +191.875°C and the data format is offset binary (see [Table 5.2](#)).

Bit 1 - DAVG_DIS - Disables the dynamic averaging feature on all temperature channels.

- '0' (default) - The dynamic averaging feature is enabled. All temperature channels will be converted with an averaging factor that is based on the conversion rate as shown in [Table 6.6](#).
- '1' - The dynamic averaging feature is disabled. All temperature channels will be converted with a maximum averaging factor of 1x (equivalent to 11-bit conversion). For higher conversion rates, this averaging factor will be reduced as shown in [Table 6.6](#).

6.5 Conversion Rate Register 04h / 0Ah

Table 6.5 Conversion Rate Register

| ADDR | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|------|-----|-----------------|----|----|----|----|-----------|----|----|----------------|---------|
| 04h | R/W | Conversion Rate | - | - | - | - | CONV[3:0] | | | 06h (4/sec) | |
| 0Ah | | | | | | | | | | | |

The Conversion Rate Register controls how often the temperature measurement channels are updated and compared against the limits. This register is fully accessible at either address.

Bits 3-0 - CONV[3:0] - Determines the conversion rate as shown in [Table 6.6](#).

Table 6.6 Conversion Rate

| CONV[3:0] | | | | | CONVERSIONS / SECOND |
|-----------|------------|---|---|---|----------------------|
| HEX | 3 | 2 | 1 | 0 | |
| 0h | 0 | 0 | 0 | 0 | / 16 |
| 1h | 0 | 0 | 0 | 1 | 1 / 8 |
| 2h | 0 | 0 | 1 | 0 | 1 / 4 |
| 3h | 0 | 0 | 1 | 1 | 1 / 21 |
| 4h | 0 | 1 | 0 | 0 | 1 |
| 5h | 0 | 1 | 0 | 1 | 2 |
| 6h | 0 | 1 | 1 | 0 | 4 (default) |
| 7h | 0 | 1 | 1 | 1 | 8 |
| 8h | 1 | 0 | 0 | 0 | 16 |
| 9h | 1 | 0 | 0 | 1 | 32 |
| Ah | 1 | 0 | 1 | 0 | 64 |
| Bh - Fh | All others | | | | 1 |

6.6 Limit Registers

Table 6.7 Temperature Limit Registers

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|-------------------------------------|-----|------|-------|----|----|----|----|----|------------|
| 05h | R/W | Internal Diode High Limit | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 55h (85°C) |
| 0Bh | | | | | | | | | | | |
| 06h | R/W | Internal Diode Low Limit | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 00h (0°C) |
| 0Ch | | | | | | | | | | | |
| 07h | R/W | External Diode High Limit High Byte | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 55h (85°C) |
| 0Dh | | | | | | | | | | | |
| 13h | R/W | External Diode High Limit Low Byte | 0.5 | 0.25 | 0.125 | - | - | - | - | - | 00h |

Table 6.7 Temperature Limit Registers (continued)

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|------------------------------------|-----|------|-------|----|----|----|----|----|-----------|
| 08h | R/W | External Diode Low Limit High Byte | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 00h (0°C) |
| 0Eh | | | | | | | | | | | |
| 14h | R/W | External Diode Low Limit Low Byte | 0.5 | 0.25 | 0.125 | - | - | - | - | - | 00h |

The device contains both high and low limits for all temperature channels. If the measured temperature exceeds the high limit, then the corresponding status bit is set and the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is asserted. Likewise, if the measured temperature is less than or equal to the low limit, the corresponding status bit is set and the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is asserted.

The data format for the limits must match the selected data format for the temperature so that if the extended temperature range is used, the limits must be programmed in the extended data format.

The limit registers with multiple addresses are fully accessible at either address.

When the device is in Standby mode, updating the limit registers will have no effect until the next conversion cycle occurs. This can be initiated via a write to the One Shot Register (see [Section 6.8, "One Shot Register 0Fh"](#)) or by clearing the RUN / STOP bit (see [Section 6.4, "Configuration Register 03h / 09h"](#)).

6.7 Scratchpad Registers 11h and 12h

Table 6.8 Scratchpad Register

| ADDR | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|------|-----|------------|----|----|----|----|----|----|----|----|---------|
| 11h | R/W | Scratchpad | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | 00h |
| 12h | R/W | Scratchpad | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | 00h |

The Scratchpad Registers are Read / Write registers that are used for place holders to be software compatible with legacy programs. Reading from the registers will return what is written to them.

6.8 One Shot Register 0Fh

The One Shot Register is used to initiate a one shot command. Writing to the one shot register when the device is in Standby mode and BUSY bit (in Status Register) is '0', will immediately cause the ADC to update all temperature measurements. Writing to the One Shot Register while the device is in Active mode will have no effect.

6.9 Therm Limit Registers

Table 6.9 Therm Limit Registers

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|----------------------------|-----|----|----|----|----|----|----|----|------------|
| 19h | R/W | External Diode Therm Limit | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 55h (85°C) |
| 20h | R/W | Internal Diode Therm Limit | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 55h (85°C) |
| 21h | R/W | Therm Hysteresis | 128 | 64 | 32 | 16 | 8 | 4 | 2 | 1 | 0Ah (10°C) |

The Therm Limit Registers are used to determine whether a critical thermal event has occurred. If the measured temperature exceeds the Therm Limit, the $\overline{\text{THERM}}$ pin is asserted. The limit setting must match the chosen data format of the temperature reading registers.

Unlike the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin, the $\overline{\text{THERM}}$ pin cannot be masked. Additionally, the $\overline{\text{THERM}}$ pin will be released once the temperature drops below the corresponding threshold minus the Therm Hysteresis.

6.10 Channel Mask Register 1Fh

Table 6.10 Channel Mask Register

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|--------------|----|----|----|----|----|----|----------|----------|---------|
| 1Fh | R/W | Channel Mask | - | - | - | - | - | - | EXT MASK | INT MASK | 00h |

The Channel Mask Register controls individual channel masking. When a channel is masked, the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will not be asserted when the masked channel reads a diode fault or out of limit error. The channel mask does not mask the $\overline{\text{THERM}}$ pin.

Bit 1 - EXTMASK - Masks the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin from asserting when the External Diode channel is out of limit or reports a diode fault.

- '0' (default) - The External Diode channel will cause the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin to be asserted if it is out of limit or reports a diode fault.
- '1' - The External Diode channel will not cause the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin to be asserted if it is out of limit or reports a diode fault.

Bit 0 - INTMASK - Masks the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin from asserting when the Internal Diode temperature is out of limit.

- '0' (default) - The Internal Diode channel will cause the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin to be asserted if it is out of limit.
- '1' - The Internal Diode channel will not cause the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin to be asserted if it is out of limit.

6.11 Consecutive ALERT Register 22h

Table 6.11 Consecutive ALERT Register

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|-------------------|----------|------------|----|----|------------|----|----|----|---------|
| 22h | R/W | Consecutive ALERT | TIME OUT | CTHRM[2:0] | | | CALRT[2:0] | | | - | 70h |

The Consecutive ALERT Register determines how many times an out-of-limit error or diode fault must be detected in consecutive measurements before the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ or $\overline{\text{THERM}}$ pin is asserted. Additionally, the Consecutive ALERT Register controls the SMBus Timeout functionality.

An out-of-limit condition (i.e. HIGH, LOW, or FAULT) occurring on the same temperature channel in consecutive measurements will increment the consecutive alert counter. The counters will also be reset if no out-of-limit condition or diode fault condition occurs in a consecutive reading.

When the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is configured as an interrupt, when the consecutive alert counter reaches its programmed value, the following will occur: the $\overline{\text{STATUS}}$ bit(s) for that channel and the last error condition(s) (i.e. EHIGH) will be set to '1', the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will be asserted, the consecutive alert counter will be cleared, and measurements will continue.

When the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is configured as a comparator, the consecutive alert counter will ignore diode fault and low limit errors and only increment if the measured temperature exceeds the High Limit. Additionally, once the consecutive alert counter reaches the programmed limit, the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will be asserted, but the counter will not be reset. It will remain set until the temperature drops below the High Limit minus the Therm Hysteresis value.

For example, if the CALRT[2:0] bits are set for 4 consecutive alerts on an EMC1182 device, the high limits are set at 70°C, and none of the channels are masked, the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin will be asserted after the following four measurements:

1. Internal Diode reads 71°C and the external diode reads 69°C. Consecutive alert counter for INT is incremented to 1.
2. Both the Internal Diode and the External Diode read 71°C. Consecutive alert counter for INT is incremented to 2 and for EXT is set to 1.
3. The External Diode reads 71°C and the Internal Diode reads 69°C. Consecutive alert counter for INT is cleared and EXT is incremented to 2.
4. The Internal Diode reads 71°C and the external diode reads 71°C. Consecutive alert counter for INT is set to 1 and EXT is incremented to 3.
5. The Internal Diode reads 71°C and the external diode reads 71°C. Consecutive alert counter for INT is incremented to 2 and EXT is incremented to 4. The appropriate status bits are set for EXT and the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is asserted. EXT counter is reset to 0 and all other counters hold the last value until the next temperature measurement.

Bit 7 - TIMEOUT - Determines whether the SMBus Timeout function is enabled.

- '0' (default) - The SMBus Timeout feature is disabled. The SMCLK line can be held low indefinitely without the device resetting its SMBus protocol.
- '1' - The SMBus Timeout feature is enabled. If the SMCLK line is held low for more than t_{TIMEOUT} , the device will reset the SMBus protocol.

Bits 6-4 CTHR[2:0] - Determines the number of consecutive measurements that must exceed the corresponding Therm Limit and Hardware Thermal Shutdown Limit before the $\overline{\text{SYS_SHDN}}$ pin is asserted. All temperature channels use this value to set the respective counters. The consecutive THERM counter is incremented whenever any of the measurements exceed the corresponding Therm Limit or if the External Diode measurement exceeds the Hardware Thermal Shutdown Limit.

If the temperature drops below the Therm Limit or Hardware Thermal Shutdown Limit, the counter is reset. If the programmed number of consecutive measurements exceed the Therm Limit or Hardware Thermal Shutdown Limit, and the appropriate channel is linked to the SYS_SHDN pin, the SYS_SHDN pin will be asserted low.

Once the $\overline{\text{SYS_SHDN}}$ pin is asserted, the consecutive Therm counter will not reset until the corresponding temperature drops below the appropriate limit minus the corresponding hysteresis.

Bits 6-4 - CTHRM[2:0] - Determines the number of consecutive measurements that must exceed the corresponding Therm Limit before the $\overline{\text{THERM}}$ pin is asserted. All temperature channels use this value to set the respective counters. The consecutive Therm counter is incremented whenever any measurement exceed the corresponding Therm Limit.

If the temperature drops below the Therm Limit, the counter is reset. If a number of consecutive measurements above the Therm Limit occurs, the $\overline{\text{THERM}}$ pin is asserted low.

Once the $\overline{\text{THERM}}$ pin has been asserted, the consecutive therm counter will not reset until the corresponding temperature drops below the Therm Limit minus the Therm Hysteresis value.

The bits are decoded as shown in Table 6.12. The default setting is 4 consecutive out of limit conversions.

Bits 3-1 - CALRT[2:0] - Determine the number of consecutive measurements that must have an out of limit condition or diode fault before the $\overline{\text{ALERT}}$ / $\overline{\text{THERM2}}$ pin is asserted. Both temperature channels use this value to set the respective counters. The bits are decoded as shown in Table 6.12. The default setting is 1 consecutive out of limit conversion.

Table 6.12 Consecutive Alert / Therm Settings

| 2 | 1 | 0 | NUMBER OF CONSECUTIVE OUT OF LIMIT MEASUREMENTS |
|---|---|---|---|
| 0 | 0 | 0 | 1 (default for CALRT[2:0]) |
| 0 | 0 | 1 | 2 |
| 0 | 1 | 1 | 3 |
| 1 | 1 | 1 | 4 (default for CTHRM[2:0]) |

6.12 Beta Configuration Register 25h

Table 6.13 Beta Configuration Register

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|-----------------------------------|----|----|----|----|--------|-----------|----|----|---------|
| 25h | R/W | External Diode Beta Configuration | - | - | - | - | ENABLE | BETA[2:0] | | | 08h |

This register is used to set the Beta Compensation factor that is used for the external diode channel.

■ '0' - The Beta Compensation Factor auto-detection circuitry is disabled.

'1' (default) - The Beta Compensation factor auto-detection circuitry is enabled. At the beginning of every conversion, the optimal Beta Compensation factor setting will be determined and applied.

6.13 External Diode Ideality Factor Register 27h

Table 6.14 Ideality Configuration Registers

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|--------------------------------|----|----|---------------|----|----|----|----|----|---------|
| 27h | R/W | External Diode Ideality Factor | - | - | IDEALITY[5:0] | | | | | | 12h |

This register stores the ideality factors that are applied to the external diode. [Table 6.15](#) defines each setting and the corresponding ideality factor. Beta Compensation and Resistance Error Correction automatically correct for most diode ideality errors; therefore, it is not recommended that these settings be updated without consulting SMSC.

Table 6.15 Ideality Factor Look-Up Table (Diode Model)

| SETTING | FACTOR | SETTING | FACTOR | SETTING | FACTOR |
|---------|--------|---------|--------|---------|--------|
| 08h | 0.9949 | 18h | 1.0159 | 28h | 1.0371 |
| 09h | 0.9962 | 19h | 1.0172 | 29h | 1.0384 |
| 0Ah | 0.9975 | 1Ah | 1.0185 | 2Ah | 1.0397 |
| 0Bh | 0.9988 | 1Bh | 1.0200 | 2Bh | 1.0410 |
| 0Ch | 1.0001 | 1Ch | 1.0212 | 2Ch | 1.0423 |
| 0Dh | 1.0014 | 1Dh | 1.0226 | 2Dh | 1.0436 |
| 0Eh | 1.0027 | 1Eh | 1.0239 | 2Eh | 1.0449 |
| 0Fh | 1.0040 | 1Fh | 1.0253 | 2Fh | 1.0462 |
| 10h | 1.0053 | 20h | 1.0267 | 30h | 1.0475 |
| 11h | 1.0066 | 21h | 1.0280 | 31h | 1.0488 |
| 12h | 1.0080 | 22h | 1.0293 | 32h | 1.0501 |
| 13h | 1.0093 | 23h | 1.0306 | 33h | 1.0514 |
| 14h | 1.0106 | 24h | 1.0319 | 34h | 1.0527 |
| 15h | 1.0119 | 25h | 1.0332 | 35h | 1.0540 |
| 16h | 1.0133 | 26h | 1.0345 | 36h | 1.0553 |
| 17h | 1.0146 | 27h | 1.0358 | 37h | 1.0566 |

For CPU substrate transistors that require the BJT transistor model, the ideality factor behaves slightly differently than for discrete diode-connected transistors. Refer to [Table 6.16](#) when using a CPU substrate transistor.

Table 6.16 Substrate Diode Ideality Factor Look-Up Table (BJT Model)

| SETTING | FACTOR | SETTING | FACTOR | SETTING | FACTOR |
|---------|--------|---------|--------|---------|--------|
| 08h | 0.9869 | 18h | 1.0079 | 28h | 1.0291 |
| 09h | 0.9882 | 19h | 1.0092 | 29h | 1.0304 |
| 0Ah | 0.9895 | 1Ah | 1.0105 | 2Ah | 1.0317 |
| 0Bh | 0.9908 | 1Bh | 1.0120 | 2Bh | 1.0330 |
| 0Ch | 0.9921 | 1Ch | 1.0132 | 2Ch | 1.0343 |
| 0Dh | 0.9934 | 1Dh | 1.0146 | 2Dh | 1.0356 |
| 0Eh | 0.9947 | 1Eh | 1.0159 | 2Eh | 1.0369 |
| 0Fh | 0.9960 | 1Fh | 1.0173 | 2Fh | 1.0382 |
| 10h | 0.9973 | 20h | 1.0187 | 30h | 1.0395 |
| 11h | 0.9986 | 21h | 1.0200 | 31h | 1.0408 |
| 12h | 1.0000 | 22h | 1.0213 | 32h | 1.0421 |
| 13h | 1.0013 | 23h | 1.0226 | 33h | 1.0434 |
| 14h | 1.0026 | 24h | 1.0239 | 34h | 1.0447 |
| 15h | 1.0039 | 25h | 1.0252 | 35h | 1.0460 |
| 16h | 1.0053 | 26h | 1.0265 | 36h | 1.0473 |
| 17h | 1.0066 | 27h | 1.0278 | 37h | 1.0486 |

APPLICATION NOTE: When measuring a 65nm Intel CPU, the Ideality Setting should be the default 12h. When measuring a 45nm Intel CPU, the Ideality Setting should be 15h.

Bit 1 - E1HIGH - This bit is set when the External Diode 1 channel exceeds its programmed high limit.

Bit 0 - IHIGH - This bit is set when the Internal Diode channel exceeds its programmed high limit.

Bit 1 - ELOW - This bit is set when the External Diode channel drops below its programmed low limit.

Bit 0 - ILOW - This bit is set when the Internal Diode channel drops below its programmed low limit.

Bit 1 - ETHERM - This bit is set when the External Diode channel exceeds its programmed Therm Limit. When set, this bit will assert the $\overline{\text{THERM}}$ pin.

Bit 0 - ITHERM - This bit is set when the Internal Diode channel exceeds its programmed Therm Limit. When set, this bit will assert the $\overline{\text{THERM}}$ pin.

6.14 Filter Control Register 40h

Table 6.17 Filter Configuration Register

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|----------------|----|----|----|----|----|----|-------------|----|---------|
| 40h | R/W | Filter Control | - | - | - | - | - | - | FILTER[1:0] | | 00h |

The Filter Configuration Register controls the digital filter on the External Diode channel.

Bits 1-0 - FILTER[1:0] - Control the level of digital filtering that is applied to the External Diode temperature measurement as shown in Table 6.18. See Figure 5.4 and Figure 5.5 for examples on the filter behavior.

Table 6.18 FILTER Decode

| FILTER[1:0] | | AVERAGING |
|-------------|---|--------------------|
| 1 | 0 | |
| 0 | 0 | Disabled (default) |
| 0 | 1 | Level 1 |
| 1 | 0 | Level 1 |
| 1 | 1 | Level 2 |

6.15 Product ID Register

Table 6.19 Product ID Register

| ADDR | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|------|-----|------------|----|----|----|----|----|----|----|----|---------|
| FDh | R | Product ID | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 20h |

The Product ID Register holds a unique value that identifies the device.

6.16 SMSC ID Register

Table 6.20 Manufacturer ID Register

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|----------|----|----|----|----|----|----|----|----|---------|
| FEh | R | SMSC ID | 0 | 1 | 0 | 1 | 1 | 1 | 0 | 1 | 5Dh |

The Manufacturer ID register contains an 8-bit word that identifies the SMSC as the manufacturer of the EMC1182.

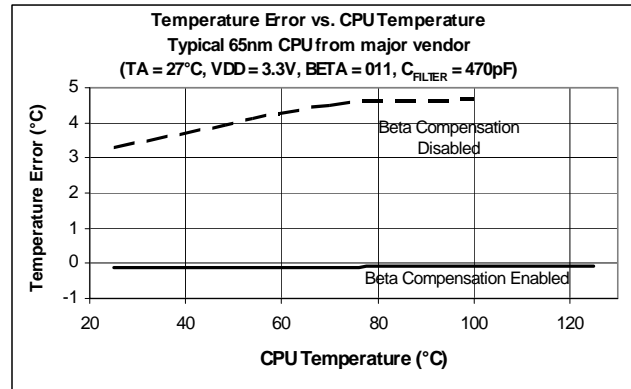
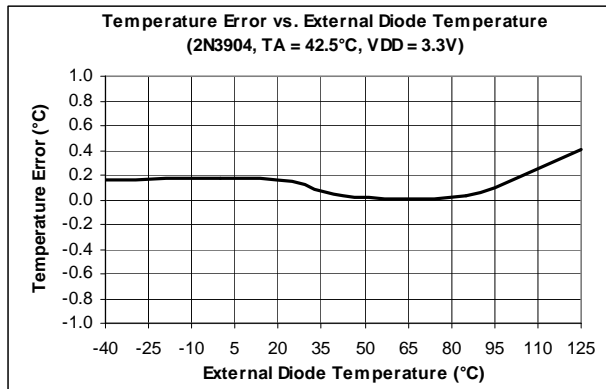
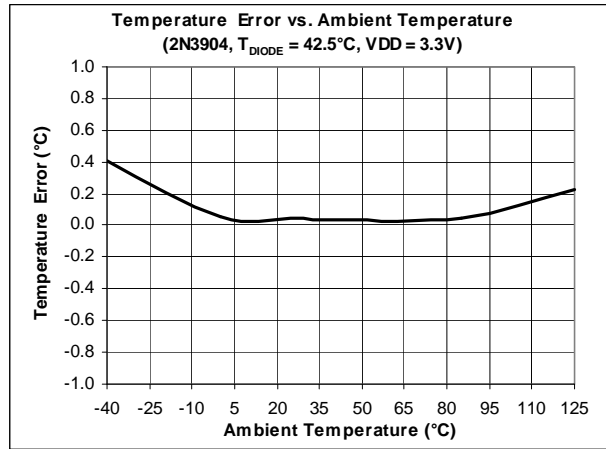
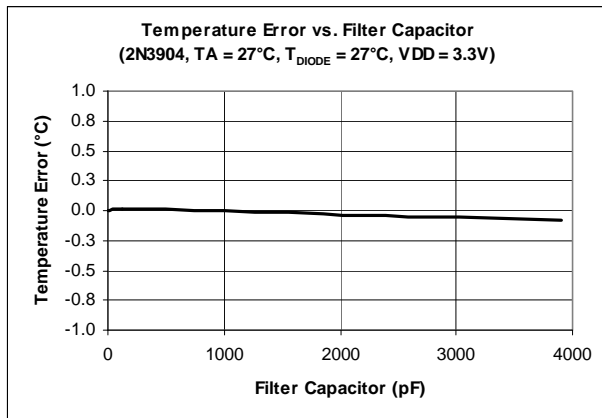
6.17 Revision Register

Table 6.21 Revision Register

| ADDR. | R/W | REGISTER | B7 | B6 | B5 | B4 | B3 | B2 | B1 | B0 | DEFAULT |
|-------|-----|----------|----|----|----|----|----|----|----|----|---------|
| FFh | R | Revision | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 07h |

The Revision register contains an 8-bit word that identifies the die revision.

Chapter 7 Typical Operating Curves



Chapter 8 Package Information

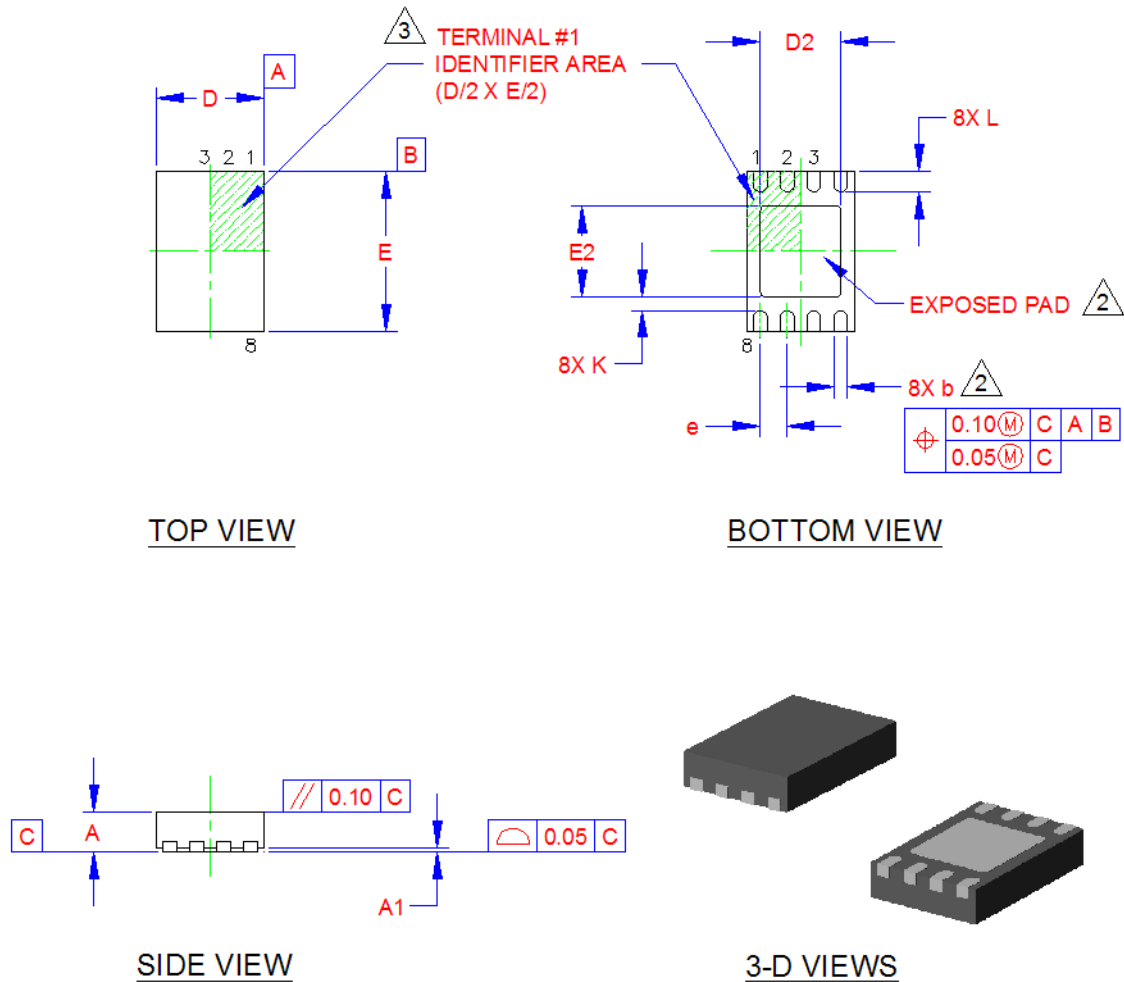


Figure 8.1 2mm x 3mm TDFN Package Drawing

| COMMON DIMENSIONS | | | | | |
|-------------------|----------|------|------|------|-----------------------------|
| SYMBOL | MIN | NOM | MAX | NOTE | REMARK |
| A | 0.70 | 0.75 | 0.80 | - | OVERALL PACKAGE HEIGHT |
| A1 | 0 | 0.02 | 0.05 | - | STANDOFF |
| D | 1.90 | 2.00 | 2.10 | - | X BODY SIZE |
| E | 2.90 | 3.00 | 3.10 | - | Y BODY SIZE |
| D2 | 1.40 | 1.50 | 1.60 | 2 | X EXPOSED PAD SIZE |
| E2 | 1.60 | 1.70 | 1.80 | 2 | Y EXPOSED PAD SIZE |
| L | 0.35 | 0.40 | 0.45 | - | TERMINAL LENGTH |
| b | 0.18 | 0.25 | 0.30 | 2 | TERMINAL WIDTH |
| K | 0.20 | 0.25 | - | - | CENTER PAD TO PIN CLEARANCE |
| e | 0.50 BSC | | | - | TERMINAL PITCH |

NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. UNILATERAL COPLANARITY ZONE APPLIES TO THE EXPOSED PAD, AS WELL AS THE TERMINALS. DIMENSIONS "b" APPLIES TO PLATED TERMINALS AND IT IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
3. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL BUT MUST BE LOCATED WITHIN THE AREA INDICATED.

Figure 8.2 2mm x 3mm TDFN Package Dimensions

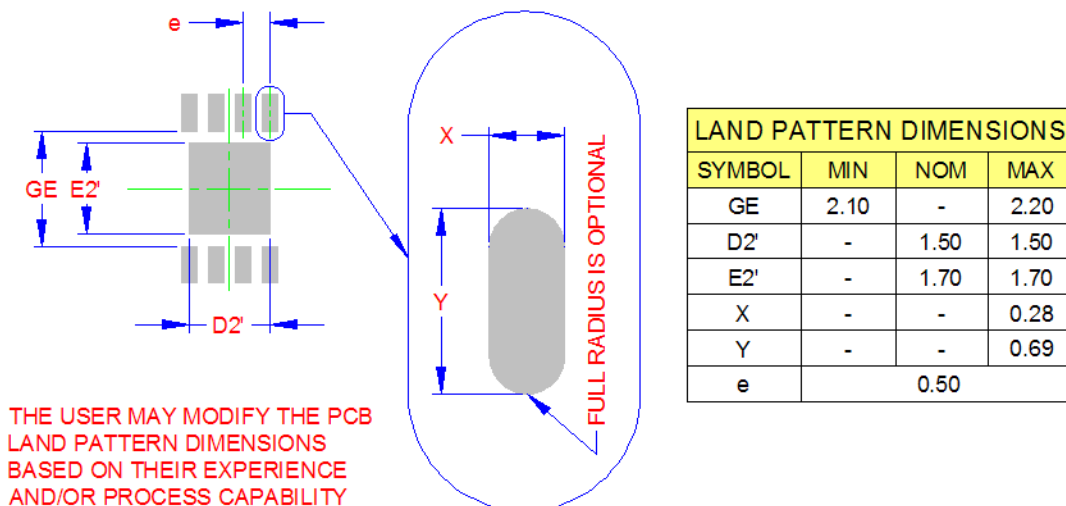
RECOMMENDED PCB LAND PATTERN

Figure 8.3 2mm x 3mm TDFN Package PCB Land Pattern

8-Lead Plastic Dual Flat, No Lead Package (MF) - 3x3x0.9mm Body [DFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>

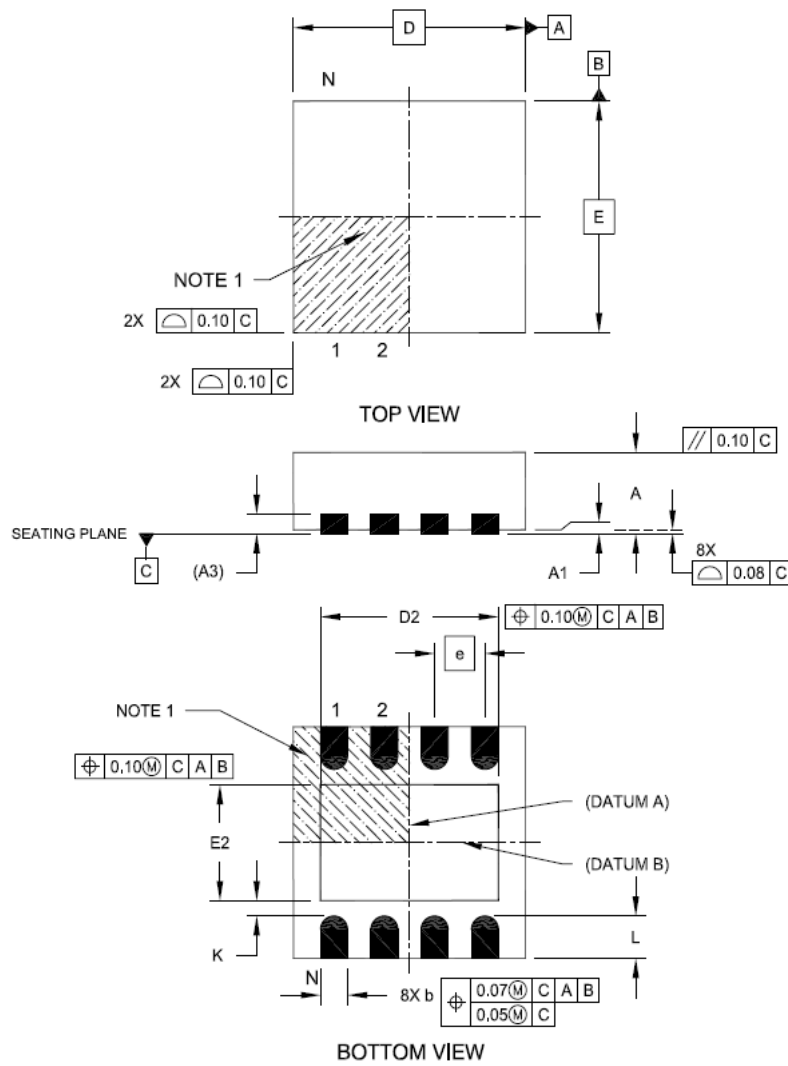
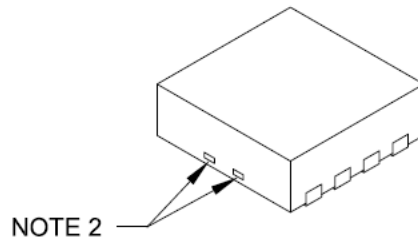


Figure 8.4 3mm x 3mm DFN Package Drawing

8-Lead Plastic Dual Flat, No Lead Package (MF) - 3x3x0.9mm Body [DFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



| Dimension Limits | Units | MILLIMETERS | | |
|------------------------|-------|-------------|------|------|
| | | MIN | NOM | MAX |
| Number of Pins | N | 8 | | |
| Pitch | e | 0.65 BSC | | |
| Overall Height | A | 0.80 | 0.90 | 1.00 |
| Standoff | A1 | 0.00 | 0.02 | 0.05 |
| Contact Thickness | A3 | 0.20 REF | | |
| Overall Length | D | 3.00 BSC | | |
| Exposed Pad Width | E2 | 1.34 | - | 1.60 |
| Overall Width | E | 3.00 BSC | | |
| Exposed Pad Length | D2 | 1.60 | - | 2.40 |
| Contact Width | b | 0.25 | 0.30 | 0.35 |
| Contact Length | L | 0.20 | 0.30 | 0.55 |
| Contact-to-Exposed Pad | K | 0.20 | - | - |

Notes:

- Pin 1 visual Index feature may vary, but must be located within the hatched area.
- Package may have one or more exposed tie bars at ends.
- Package is saw singulated
- Dimensioning and tolerancing per ASME Y14.5M

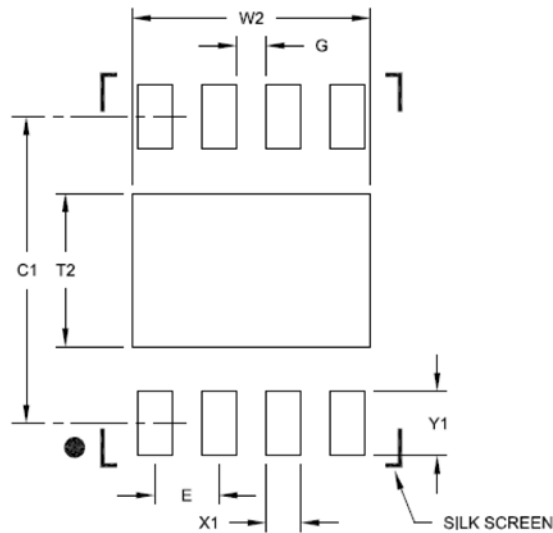
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Figure 8.5 3mm x 3mm DFN Package Dimensions

8-Lead Plastic Dual Flat, No Lead Package (MF) - 3x3x0.9mm Body [DFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

| Dimension Limits | Units | MILLIMETERS | | |
|----------------------------|-------|-------------|------|------|
| | | MIN | NOM | MAX |
| Contact Pitch | E | 0.65 BSC | | |
| Optional Center Pad Width | W2 | | | 2.40 |
| Optional Center Pad Length | T2 | | | 1.55 |
| Contact Pad Spacing | C1 | | 3.10 | |
| Contact Pad Width (X8) | X1 | | | 0.35 |
| Contact Pad Length (X8) | Y1 | | | 0.65 |
| Distance Between Pads | G | 0.30 | | |

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension, Theoretically exact value shown without tolerances.

Figure 8.6 8 Pin DFN PCB Footprint

8.1 Package Markings

The EMC1182 devices will be marked as shown in [Figure 8.7](#), [Figure 8.8.](#), [Figure 8.9](#), [Figure 8.10](#) and [Figure 8.11](#).

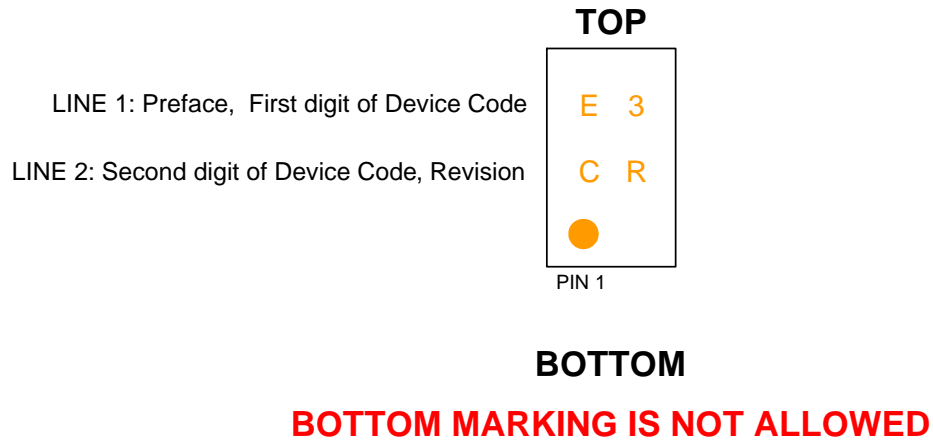


Figure 8.7 EMC1182-1 8-Pin TDFN Package Markings

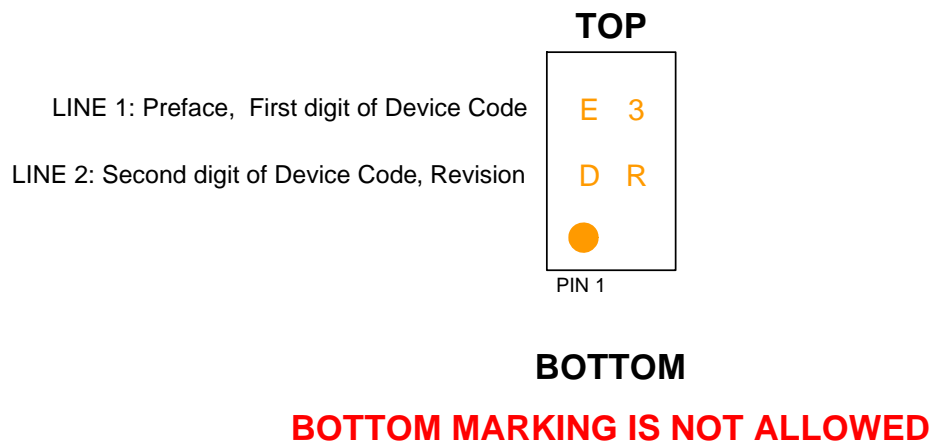


Figure 8.8 EMC1182-2 8-Pin TDFN Package Markings

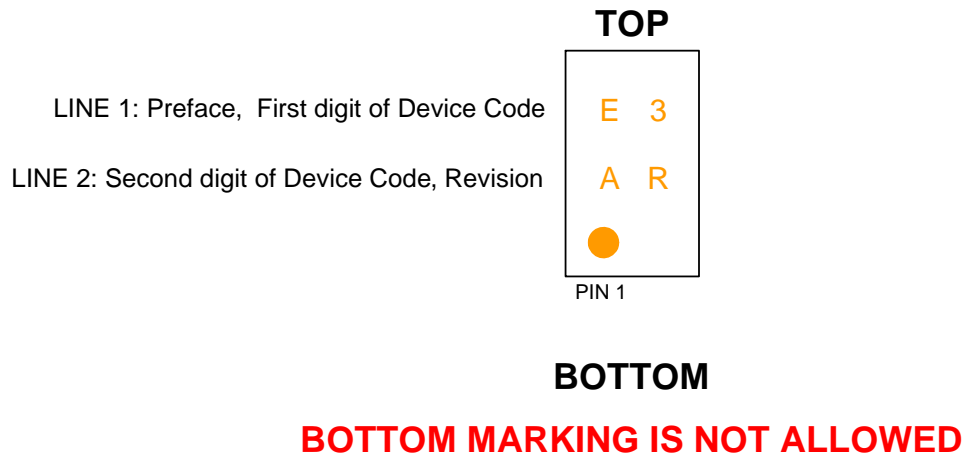


Figure 8.9 EMC1182-A 8-Pin TDFN Package Markings

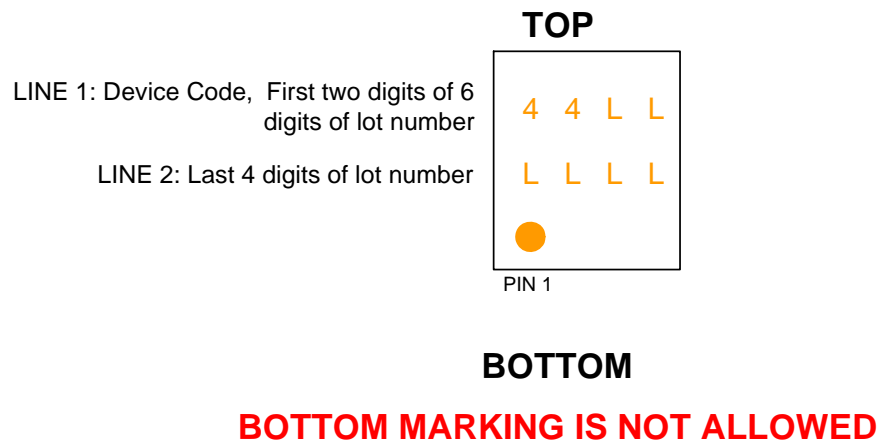


Figure 8.10 EMC1182-1 8-Pin DFN Package Markings

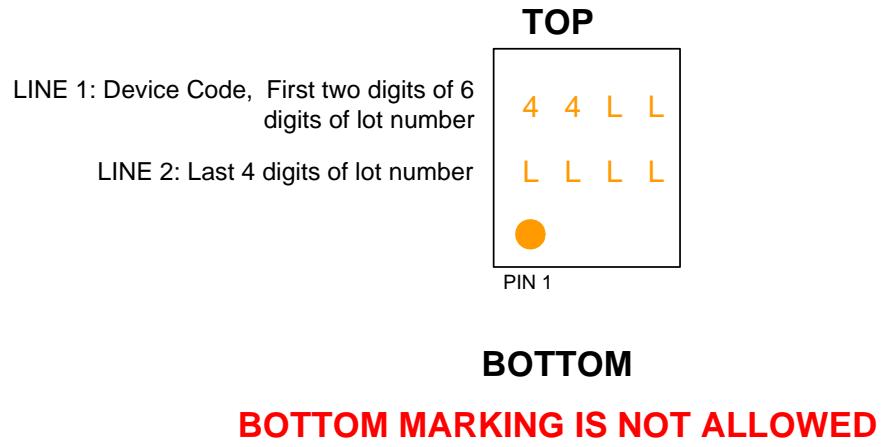


Figure 8.11 EMC1182-2 8-Pin DFN Package Markings

Chapter 9 Datasheet Revision History

Table 9.1 Customer Revision History

| REVISION LEVEL & DATE | SECTION/FIGURE/ENTRY | CORRECTION |
|----------------------------------|-----------------------------|-------------------|
| Rev. 1.0 (07-11-13) | Formal document release | |